MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 246 A

Features

- Low R_{DS(on)} to Improve Conduction and Overall Efficiency
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- OR-ing FET, Power Load Switch, Motor Control
- Refer to Application Note AND8195/D for Mounting Information

End Products

Motor Control, UPS, Fault-Tolerant Power Systems, Hot Swap
 MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

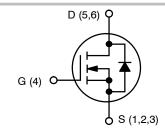
Para	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Volta	ce Voltage			±20	V
Continuous Drain Current R _{B.IA}		T _A = 25°C	I _D	40	Α
(Note 1)		T _A = 100°C		25	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	2.74	W
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s}$		T _A = 25°C	I _D	77	Α
(Note 1)		T _A = 100°C		48	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	10.2	W
Continuous Drain	State	T _A = 25°C	I _D	23	Α
Current R _{θJA} (Note 2)		T _A = 100°C		15	
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.95	W
Continuous Drain		T _C = 25°C	I _D	246	Α
Current R _{θJC} (Note 1)		T _C =100°C		156	
Power Dissipation R _{0JC} (Note 1)		T _C = 25°C	P _D	104	W
Pulsed Drain Current	T _A = 25°C, t _p = 10 μs		I _{DM}	490	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			IS	100	Α
Drain to Source DV/DT			dV/d _t	4.4	V/ns



ON Semiconductor®

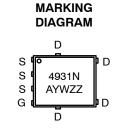
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30.1/	1.1 mΩ @ 10 V	246 A
30 V	1.5 mΩ @ 4.5 V	240 A



N-CHANNEL MOSFET





A = Assembly Location
Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4931NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4931NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 10 V, I_L = 41 A_{pk} , L = 0.3 mH, R_G = 25 Ω)	E _{AS}	252	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.2	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	45.7	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	132	*C/VV
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	12.3	

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				18		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$				1.0	
		$V_{DS} = 24 \text{ V}$	T _J = 125°C			15	- μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{G}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V V _{GS} = 4.5 V	I _D = 30 A		0.85	1.1	mΩ
			I _D = 15 A		0.82		
			I _D = 30 A		1.2	1.5	
			I _D = 15 A 1.2	1			
Forward Transconductance	9FS	V _{DS} = 1.5 V,	I _D = 15 A		86		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}				9821		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			2720		pF
Reverse Transfer Capacitance	C _{RSS}				234		
Total Gate Charge	Q _{G(TOT)}				61.5		
Threshold Gate Charge	Q _{G(TH)}		45.77.1 00.4		14.2		nC
Gate-to-Source Charge	Q_{GS}	V_{GS} = 4.5 V, V_{DS} =	15 V; I _D = 30 A		25.2		
Gate-to-Drain Charge	Q_{GD}	1			15.9		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			128		nC
SWITCHING CHARACTERISTICS (Note 6)	-			-	-	•	-
Turn-On Delay Time	t _{d(ON)}				27		
Rise Time	t _r	V _{GS} = 4.5 V. Vr	ne = 15 V.		29		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			36		ns
Fall Time	t _f				24		1

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

^{5.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

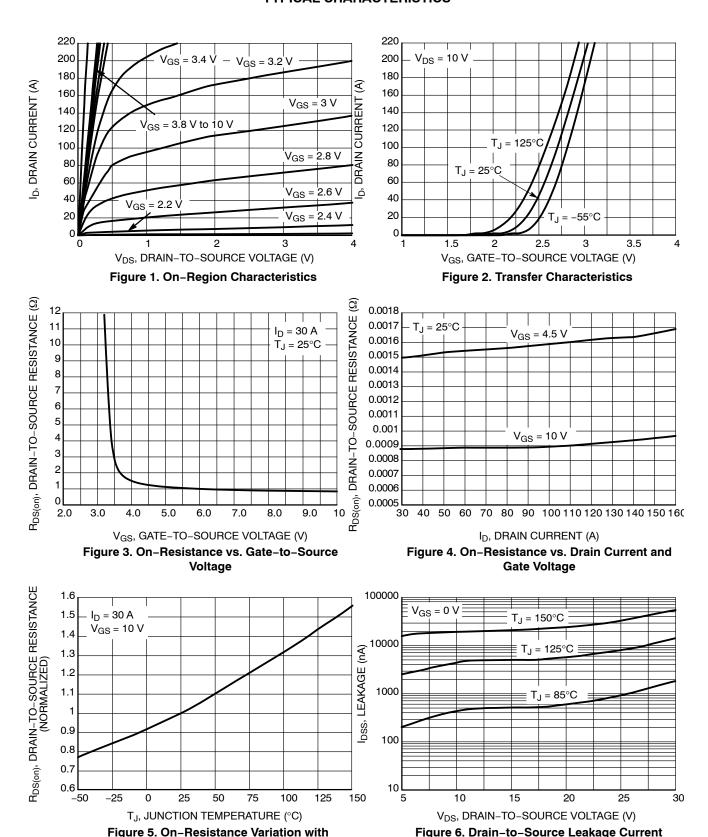
Parameter	Symbol	Test Cond	dition	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N		rest con		IVIIII	Typ	WILL	Oilit
·	· ·			1	15		
Turn-On Delay Time	t _{d(ON)}						4
Rise Time	t _r	$V_{GS} = 10 \text{ V}, \text{ V}_{D}$	_{DS} = 15 V,		17		- ns
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_C$	$_{3}=3.0~\Omega$		80		
Fall Time	t _f				22		
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		0.8	1.0		
			T _J = 125°C		0.62		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			64		ns
Charge Time	t _a				33		
Discharge Time	t _b				31		
Reverse Recovery Charge	Q_{RR}				100		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance	L _S				0.50		nH
Drain Inductance	L _D	T _A = 25°C			0.005		nH
Gate Inductance	L _G				1.84		nH
Gate Resistance	R_{G}				0.7	1.8	Ω

^{5.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{6.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



vs. Voltage

Temperature

TYPICAL CHARACTERISTICS

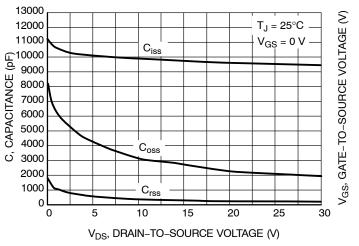


Figure 7. Capacitance Variation

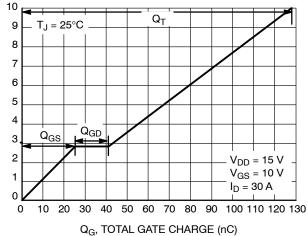


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

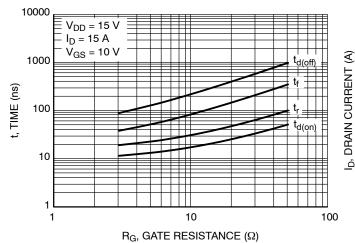


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

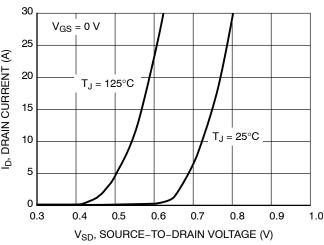


Figure 10. Diode Forward Voltage vs. Current

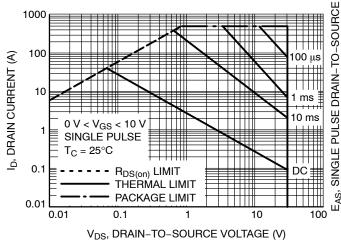


Figure 11. Maximum Rated Forward Biased Safe Operating Area

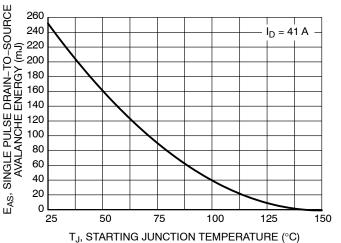


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

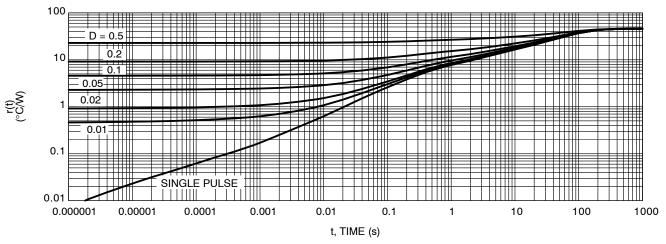


Figure 13. Thermal Response

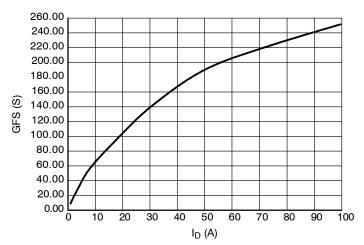


Figure 14. GFS vs. I_D



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC	;			
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
l e	0 °		12 °			

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

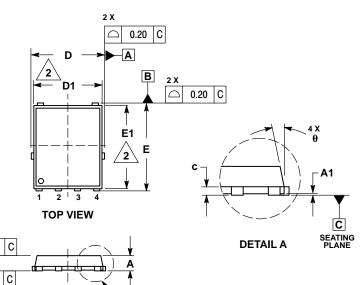
= Lot Traceability

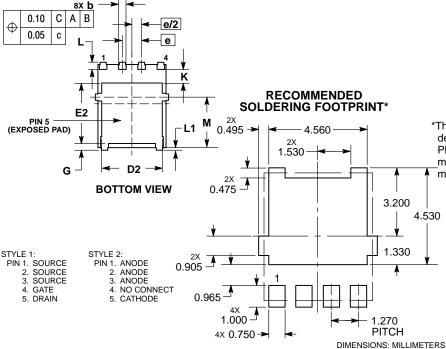
= Assembly Location Α

Υ = Year W = Work Week

ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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